Final datasheet

TRENCHSTOP™ IGBT 7 PR7 Reverse Conducting IGBT for boost PFC stage with improved EMI characteristics offering the best-in-class performance for high power and high switching frequency applications

Features

- V_{CE} = 670 V
- I_C = 70 A
- Pin-to-pin creepage distance > 4.8 mm
- Pin-to-pin clearance distance > 3.4 mm
- Optimized monolithic diode for PFC applications
- Improved EMI behavior with lower dv/dt
- Very low V_{CEsat} = 1.4 V (typ.) at 25°C
- Stable temperature behavior
- Low temperature dependence of V_{CEsat} and E_{sw}
- 2 kV ESD HBM compliant
- Easy parallel switching capability based on positive temperature coefficient of V_{CEsat}
- Product spectrum and PSpice Models: http://www.infineon.com/igbt/

Lead-free
Green
Halogen-free
RoHS

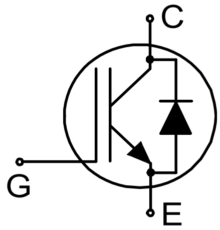
Potential applications

- Residential Aircon / Commercial Aircon
- Residential HVAC / Commercial HVAC

Product validation

- Qualified for industrial applications according to the relevant tests of JEDEC47/20/22

Description



Type	Package	Marking
IKWH70N67PR7	PG-TO247-3-U04	H70EPR7

Table of contents

1 Package

Table 1 Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Internal emitter inductance measured 5 mm (0.197 in.) from case	L_E			13		nH
Storage temperature	T_{stg}		-55		150	°C
Soldering temperature	T_{sold}	wave soldering 1.6 mm (0.063 in.) from case for 10 s			260	°C
Mounting torque	M	M3 screw, Maximum of mounting processes: 3			0.6	Nm
Thermal resistance, junction-ambient	$R_{th(j-a)}$				40	K/W
IGBT thermal resistance, junction-case	$R_{th(j-c)}$			0.48	0.62	K/W

2 IGBT

Table 2 Maximum rated values

Parameter	Symbol	Note or test condition		Values	Unit
Collector-emitter voltage	V_{CE}	$T_{vj} \geq 25$ °C		670	V
DC collector current, limited by T_{vjmax}	I_C		$T_c = 25$ °C	140	A
			$T_c = 100$ °C	85	
Pulsed collector current, t_p limited by T_{vjmax}	I_{Cpulse}			210	A
Turn-off safe operating area		$V_{CE} \leq 670$ V, $T_{vj} \leq 175$ °C		210	A
Gate-emitter voltage	V_{GE}			±20	V
Transient gate-emitter voltage	V_{GE}	$t_p \leq 0.5$ µs, $D < 0.001$		±30	V
Power dissipation	P_{tot}		$T_c = 25$ °C	313	W
			$T_c = 100$ °C	156	

Table 3 Characteristic values

Parameter	Symbol	Note or test condition		Values			Unit
				Min.	Typ.	Max.	
Collector-emitter saturation voltage	V_{CEsat}	$I_C = 70$ A, $V_{GE} = 15$ V	$T_{vj} = 25$ °C		1.4	1.75	V
			$T_{vj} = 175$ °C		1.7		

(table continues...)

Table 3 **(continued) Characteristic values**

Parameter	Symbol	Note or test condition		Values			Unit
				Min.	Typ.	Max.	
Gate-emitter threshold voltage	V_{GEth}	I_C = 0.4 mA, $V_{CE} = V_{GE}$		3.2	3.95	4.8	V
Zero gate-voltage collector current	I_{CES}	V_{CE} = 670 V, V_{GE} = 0 V	T_{vj} = 25 °C			40	mA
			T_{vj} = 175 °C		0.5		mA
Gate-emitter leakage current	I_{GES}	V_{CE} = 0 V, V_{GE} = 20 V				100	nA
Transconductance	g_{fs}	I_C = 70 A, V_{CE} = 20 V			109		S
Input capacitance	C_{ies}	V_{CE} = 25 V, V_{GE} = 0 V, f = 100 kHz			3860		pF
Output capacitance	C_{oes}	V_{CE} = 25 V, V_{GE} = 0 V, f = 100 kHz			49.4		pF
Reverse transfer capacitance	C_{res}	V_{CE} = 25 V, V_{GE} = 0 V, f = 100 kHz			19.6		pF
Gate charge	Q_G	V_{CC} = 520 V, I_C = 70 A, V_{GE} = 15 V			181		nC
Turn-on delay time	$t_{d(on)}$	V_{CC} = 400 V, V_{GE} = 0/15 V, $R_{G(on)}$ = 9.8 Ω, $R_{G(off)}$ = 9.8 Ω	T_{vj} = 25 °C, I_C = 70 A		22		ns
			T_{vj} = 175 °C, I_C = 70 A		20		
Rise time (inductive load)	t_r	V_{CC} = 400 V, V_{GE} = 0/15 V, $R_{G(on)}$ = 9.8 Ω	T_{vj} = 25 °C, I_C = 70 A		30		ns
			T_{vj} = 175 °C, I_C = 70 A		28		
Turn-off delay time	$t_{d(off)}$	V_{CC} = 400 V, V_{GE} = 0/15 V, $R_{G(on)}$ = 9.8 Ω	T_{vj} = 25 °C, I_C = 70 A		246		ns
			T_{vj} = 175 °C, I_C = 70 A		274		
Fall time (inductive load)	t_f	V_{CC} = 400 V, V_{GE} = 0/15 V, $R_{G(on)}$ = 9.8 Ω	T_{vj} = 25 °C, I_C = 70 A		40		ns
			T_{vj} = 175 °C, I_C = 70 A		32		
Turn-on energy	E_{on}	V_{CC} = 400 V, V_{GE} = 0/15 V, $R_{G(on)}$ = 9.8 Ω	T_{vj} = 25 °C, I_C = 70 A		1.58		mJ
			T_{vj} = 175 °C, I_C = 70 A		2.13		
Turn-off energy	E_{off}	V_{CC} = 400 V, V_{GE} = 0/15 V, $R_{G(on)}$ = 9.8 Ω	T_{vj} = 25 °C, I_C = 70 A		1.14		mJ
			T_{vj} = 175 °C, I_C = 70 A		1.14		

(table continues...)

Table 3 **(continued) Characteristic values**

Parameter	Symbol	Note or test condition		Values			Unit
				Min.	Typ.	Max.	
Total switching energy	E_{ts}	V_{CC} = 400 V, V_{GE} = 0/15 V, $R_{G(on)}$ = 9.8 Ω	T_{vj} = 25 °C, I_C = 70 A		2.72		mJ
			T_{vj} = 175 °C, I_C = 70 A		3.27		
Operating junction temperature	T_{vj}			-40		175	°C

3 Diode

Table 4 **Maximum rated values**

Parameter	Symbol	Note or test condition	Values	Unit
Repetitive peak reverse voltage	V_{RRM}	T_{vj} ≥ 25 °C	670	V
Diode pulsed current, t_p limited by T_{vjmax}	I_{Fpulse}		5	A

Table 5 **Characteristic values**

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Operating junction temperature	T_{vj}		-40		175	°C

Note: *For optimum lifetime and reliability, Infineon recommends operating conditions that do not exceed 80% of the maximum ratings stated in this datasheet.*

Electrical Characteristic, at T_{vj} = 25°C, unless otherwise specified.

Dynamic test circuit, parasitic inductance L_σ = 30 nH, parasitic capacitor C_σ = 23 pF from Fig. C.

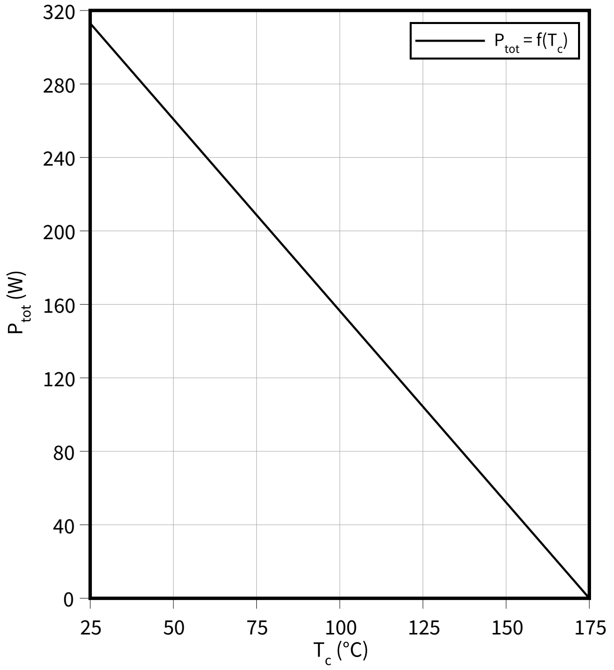
2nd device for EC7 Diode = IDWD75E65E7

4 Characteristics diagrams

Power dissipation as a function of case temperature

$P_{tot} = f(T_c)$

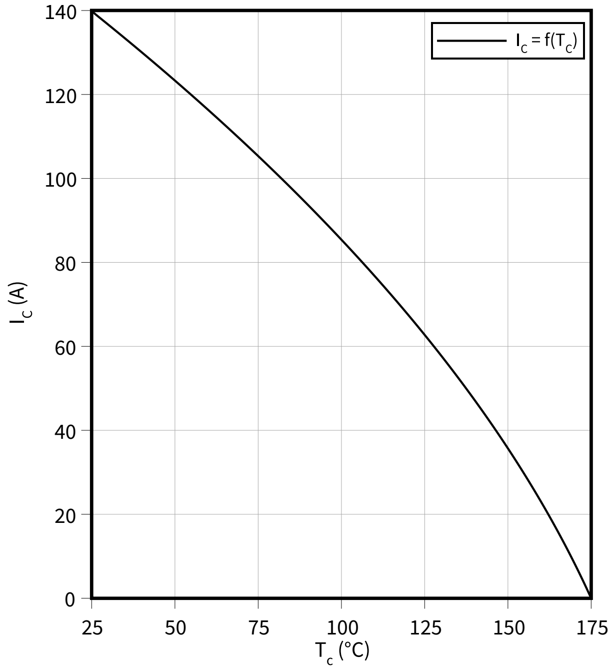
$T_{vj} \leq 175\ °C$



Collector current as a function of case temperature

$I_C = f(T_c)$

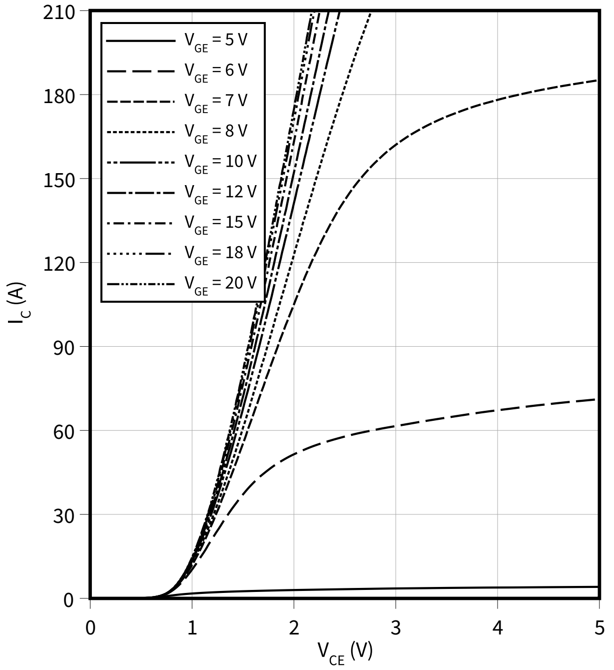
$T_{vj} \leq 175\ °C$, $V_{GE} \geq 15\ V$



Typical output characteristic

$I_C = f(V_{CE})$

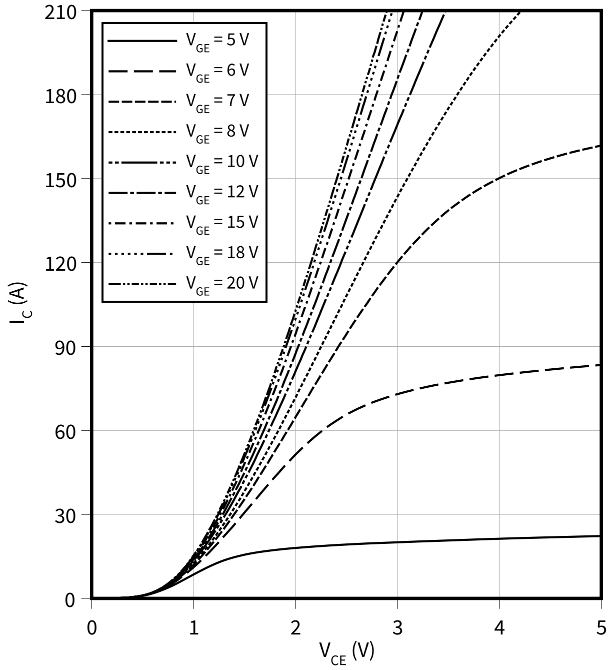
$T_{vj} = 25\ °C$



Typical output characteristic

$I_C = f(V_{CE})$

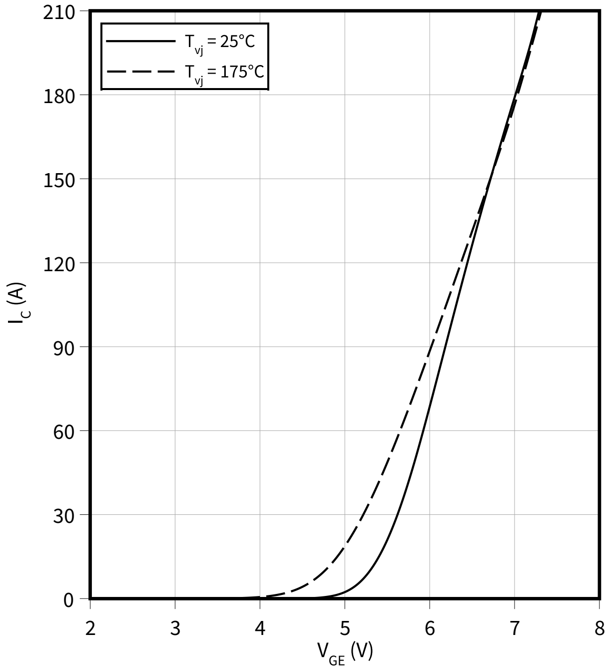
$T_{vj} = 175\ °C$



Typical transfer characteristic

$I_C = f(V_{GE})$

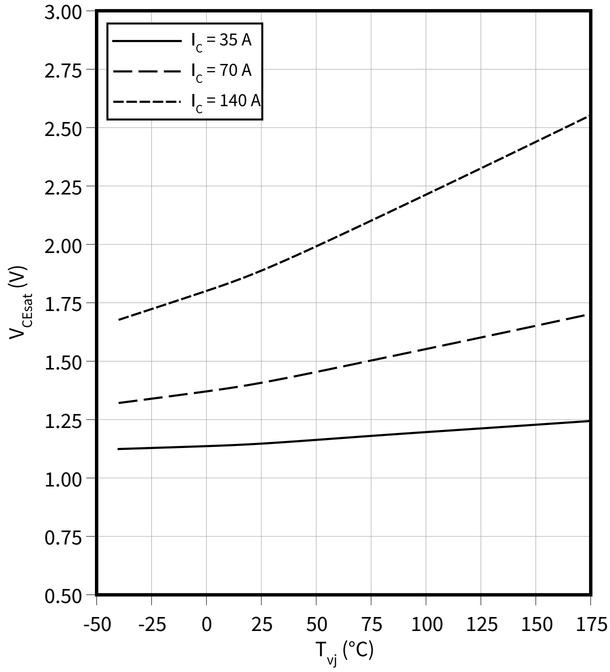
$V_{CE} = 20$ V



Typical collector-emitter saturation voltage as a function of junction temperature

$V_{CEsat} = f(T_{vj})$

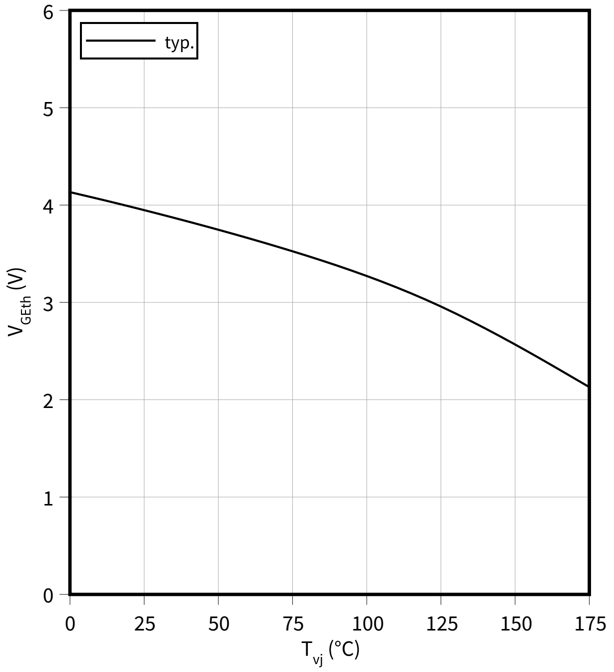
$V_{GE} = 15$ V



Gate-emitter threshold voltage as a function of junction temperature

$V_{GEth} = f(T_{vj})$

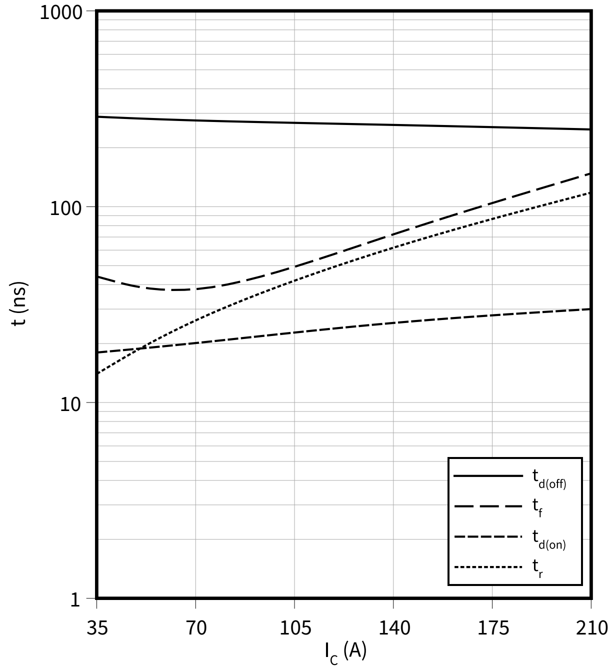
$I_C = 0.2$ mA

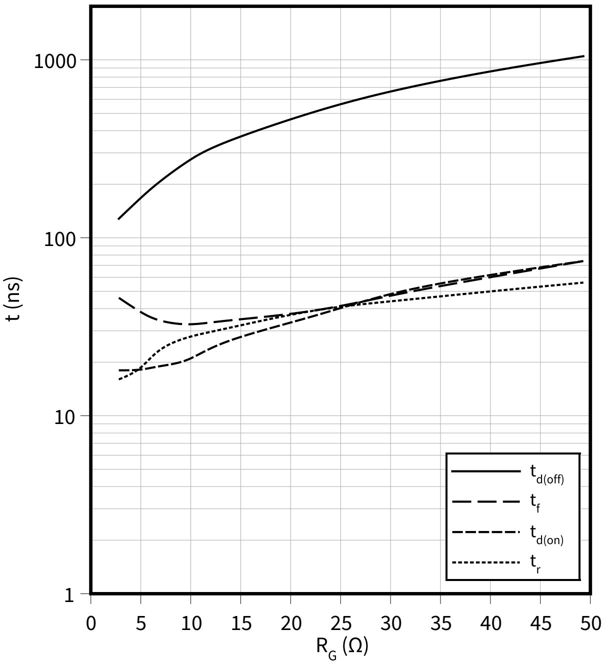
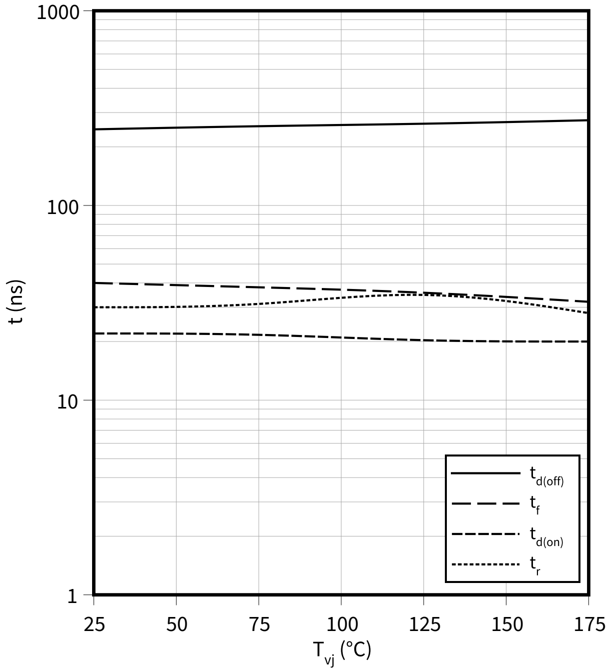


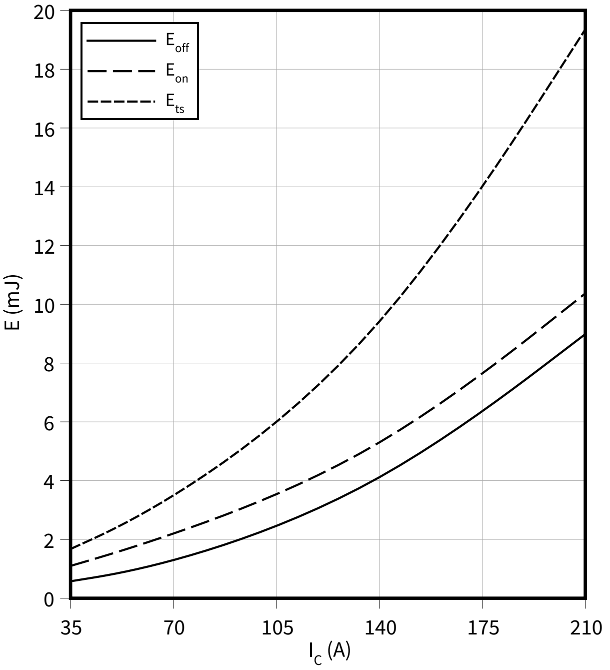
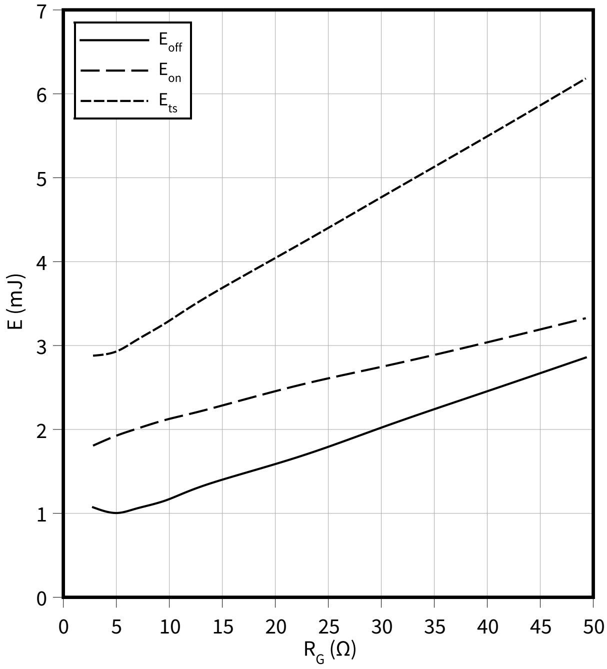
Typical switching times as a function of collector current

$t = f(I_C)$

$V_{CC} = 400$ V, $T_{vj} = 175$ °C, $V_{GE} = 0/15$ V, $R_G = 9.8\ \Omega$



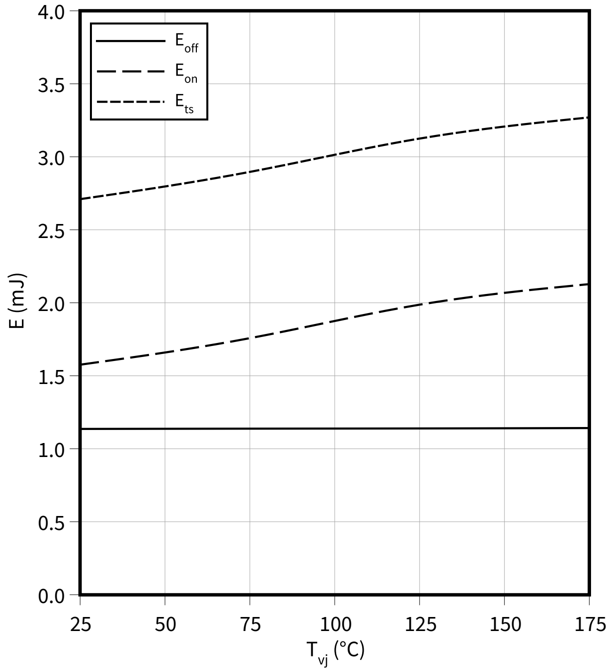
Typical switching times as a function of gate resistor $t = f(R_G)$ I_C = 70 A, V_{CC} = 400 V, T_{vj} = 175 °C, V_{GE} = 0/15 V	**Typical switching times as a function of junction temperature** $t = f(T_{vj})$ I_C = 70 A, V_{CC} = 400 V, V_{GE} = 0/15 V, R_G = 9.8 Ω
	

Typical switching energy losses as a function of collector current $E = f(I_C)$ V_{CC} = 400 V, T_{vj} = 175 °C, V_{GE} = 0/15 V, R_G = 9.8 Ω	**Typical switching energy losses as a function of gate resistor** $E = f(R_G)$ I_C = 70 A, V_{CC} = 400 V, T_{vj} = 175 °C, V_{GE} = 0/15 V
	

Typical switching energy losses as a function of junction temperature

$E = f(T_{vj})$

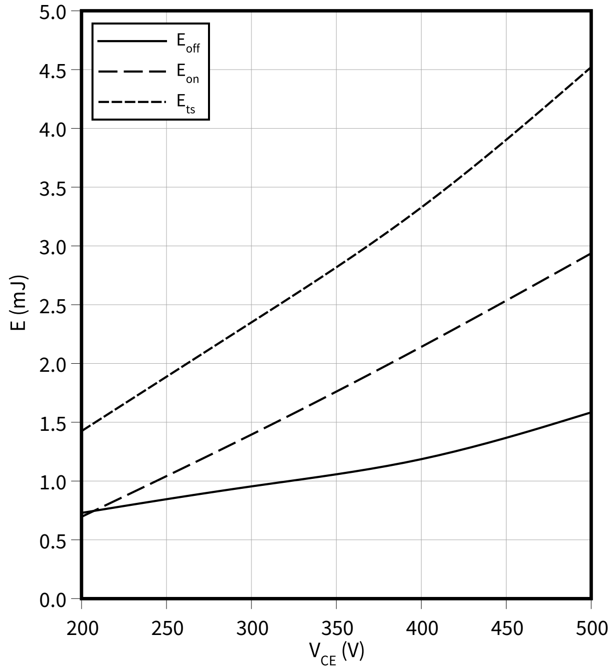
$I_C = 70$ A, $V_{CC} = 400$ V, $V_{GE} = 0/15$ V, $R_G = 9.8$ Ω



Typical switching energy losses as a function of collector emitter voltage

$E = f(V_{CE})$

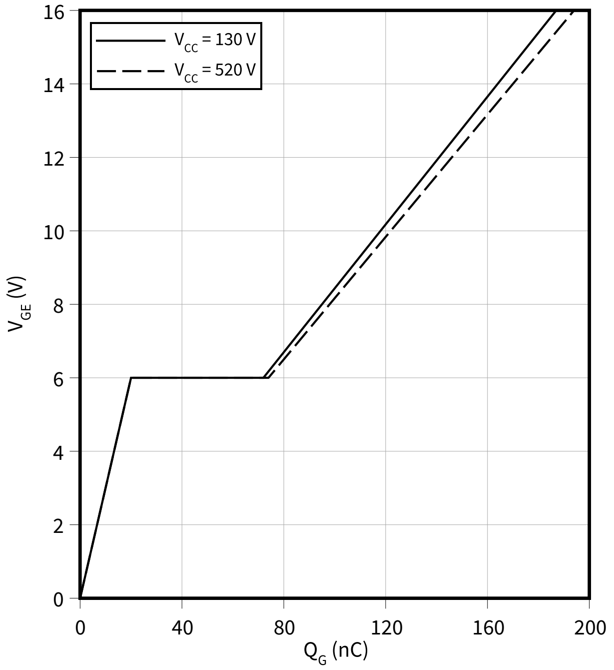
$I_C = 70$ A, $T_{vj} = 175$ °C, $V_{GE} = 0/15$ V, $R_G = 9.8$ Ω



Typical gate charge

$V_{GE} = f(Q_G)$

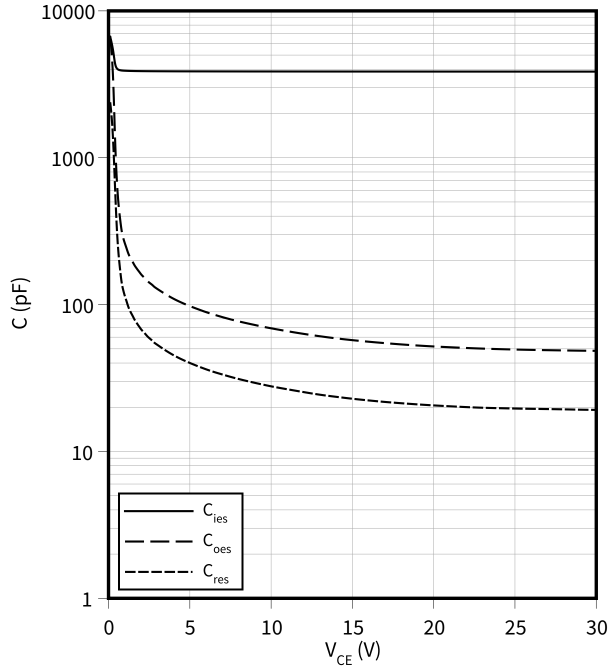
$I_C = 70$ A



Typical capacitance as a function of collector-emitter voltage

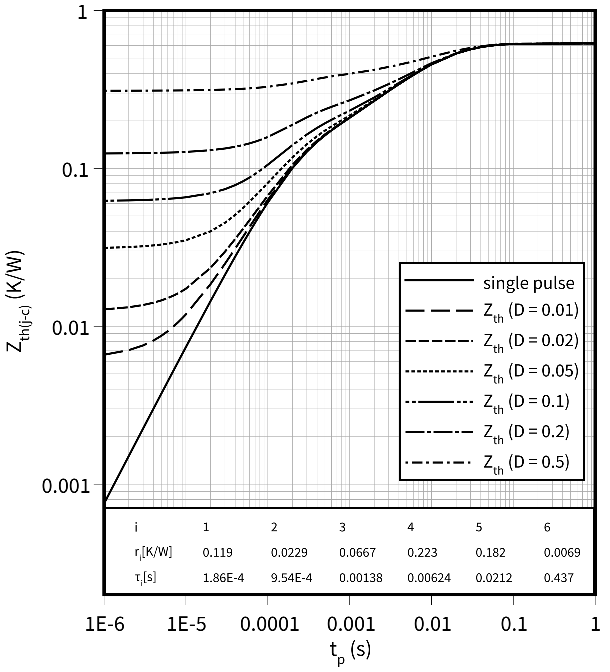
$C = f(V_{CE})$

$f = 100$ kHz, $V_{GE} = 0$ V

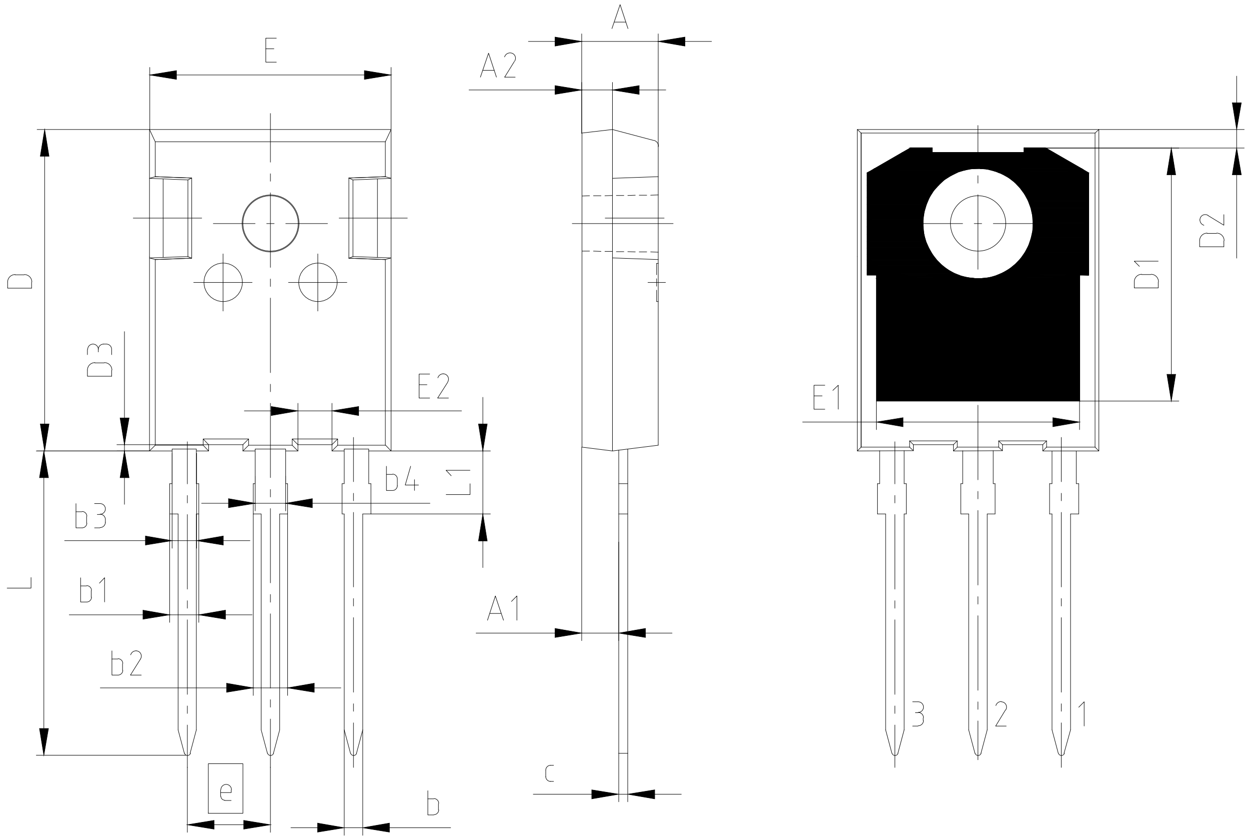


IGBT transient thermal impedance as a function of pulse width

$Z_{th(j-c)} = f(t_p)$
$D = t_p/T$



5 Package outlines



PACKAGE - GROUP NUMBER:	PG-TO247-3-U04	
DIMENSIONS	**MILLIMETERS**	
	MIN.	MAX.
A	4.90	5.10
A1	2.31	2.51
A2	1.90	2.10
b	1.16	1.26
b1		1.90
b2		2.30
b3	1.55	1.65
b4	1.96	2.06
c	0.59	0.66
D	20.90	21.10
D1	16.25	16.85
D2	1.05	1.35
D3	0.55	0.65
E	15.70	15.90
E1	13.10	13.50
E2	2.14	2.34
e	5.44	
N	3	
L	19.80	20.10
L1	3.95	4.30

Figure 1

6 Testing conditions

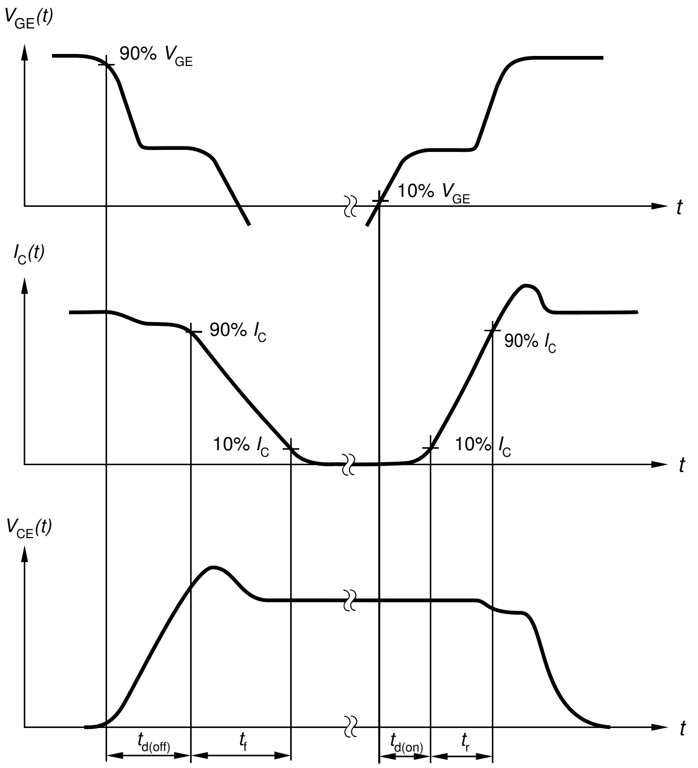


Figure A. **Definition of switching times**

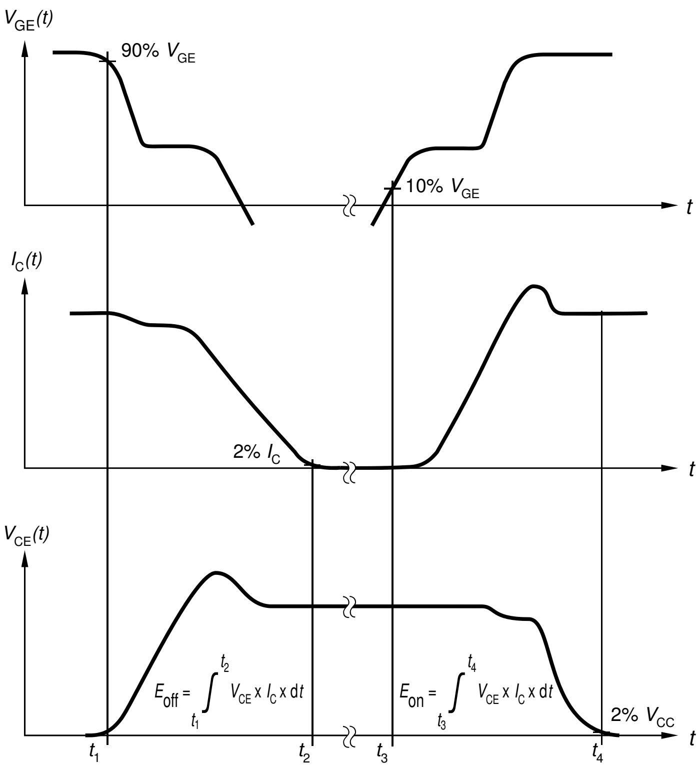


Figure B. **Definition of switching losses**

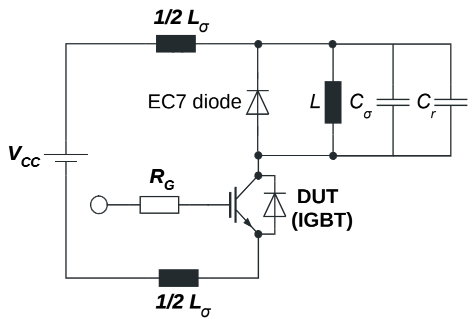


Figure C. **Dynamic test circuit**

Parasitic inductance L_σ,
parasitic capacitor C_σ,
relief capacitor C_r,
(only for ZVT switching)

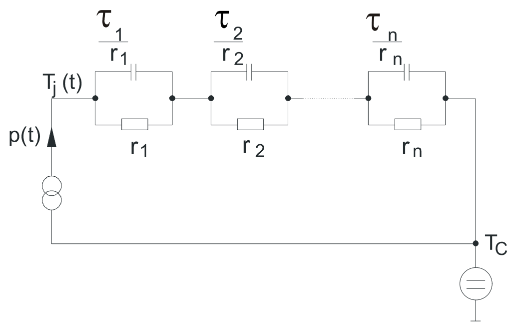


Figure D. **Termal equivalent circuit**

Figure 2

Revision history

Document revision	Date of release	Description of changes
0.10	2024-08-13	Preliminary datasheet
1.00	2024-09-20	Final datasheet

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